UHF power LDMOS transistor Rev. 2 — 12 July 2013

Product data sheet

Product profile 1.

1.1 General description

A 650 W LDMOS RF power transistor for broadcast transmitter applications and industrial applications. The excellent ruggedness of this device makes it ideal for digital and analog transmitter applications.

Application information Table 1.

RF performance at $V_{DS} = 50$ V unless otherwise specified.

	P _{L(AV)}	P _{L(M)}	Gp	η _D	IMD3	IMD _{shldr}	PAR
IHz) ((W)	(W)	(dB)	(%)	(dBc)	(dBc)	(dB)
RF performance in a common source 860 MHz narrowband test circuit							
= 860; f ₂ = 860.1	250	-	21	46	-34	-	-
i8 ·	120	-	21	33	-	-31 <mark>11</mark>	8.2 [2]
mmon source 470	MHz to	860 MI	lz bro	adba	nd test	circuit	
8	120	-	20	32	-	-32 <mark>[1]</mark>	8.0 [2]
	mmon source 860 = 860; f ₂ = 860.1 8 mmon source 470	mmon source 860 MHz na = 860; f ₂ = 860.1 250 8 120 mmon source 470 MHz to	mmon source 860 MHz narrowba = 860; f ₂ = 860.1 250 8 120 mmon source 470 MHz to 860 MHz	mmon source 860 MHz narrowband test = 860; f ₂ = 860.1 250 - 21 8 120 - 21 mmon source 470 MHz to 860 MHz bro 120 - 120	mmon source 860 MHz narrowband test circ = 860; f ₂ = 860.1 250 - 21 46 8 120 - 21 33 mmon source 470 MHz to 860 MHz broadba	mmon source 860 MHz narrowband test circuit = 860; f ₂ = 860.1 250 - 21 46 -34 8 120 - 21 33 - mmon source 470 MHz to 860 MHz broadband test of the second seco	mmon source 860 MHz narrowband test circuit = 860; f ₂ = 860.1 250 - 21 46 -34 - 8 120 - 21 33 - -31 ^[1] mmon source 470 MHz to 860 MHz broadband test circuit

[1] Measured [dBc] with delta marker at 4.3 MHz from center frequency.

[2] PAR (of output signal) at 0.01 % probability on CCDF; PAR of input signal = 9.5 dB at 0.01 % probability on CCDF.

1.2 Features and benefits

- Excellent ruggedness
- Optimum thermal behavior and reliability, R_{th(i-c)} = 0.15 K/W
- High power gain
- High efficiency
- Designed for broadband operation (470 MHz to 860 MHz)
- Internal input matching for high gain and optimum broadband operation
- Excellent reliability
- Easy power control
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC

1.3 Applications

- Communication transmitter applications in the UHF band
- Industrial applications in the UHF band



UHF power LDMOS transistor

2. Pinning information

Pin	Description	Simplified outlin	e Graphic symbol
BLF888E	8 (SOT539A)		
1	drain1		
2	drain2		1
3	gate1		
4	gate2	3 4	
5	SOUICE	<u>[1]</u>	2 sym117
BLF888E	3S (SOT539B)		
1	drain1	1 2	1
2	drain2		، ل
3	gate1		
4	gate2	3 4	
5	source	<u>[1]</u>	

[1] Connected to flange.

3. Ordering information

Table 3.Ordering information

Type number	Package					
	Name	Description	Version			
BLF888B	-	flanged balanced LDMOST ceramic package; 2 mounting holes; 4 leads	SOT539A			
BLF888BS	-	earless flanged balanced LDMOST ceramic package; 4 leads	SOT539B			

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

			,		
Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage		-	104	V
V _{GS}	gate-source voltage		-0.5	+11	V
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	200	°C

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5. Thermal characteristics

Table 5.	Thermal characteristics				
Symbol	Parameter	Conditions	٦	Тур	Unit
R _{th(j-c)}	thermal resistance from junction to case	T_{case} = 80 °C; $P_{L(AV)}$ = 125 W	<u>[1]</u> (0.15	K/W
[1] R _{th(j-c)}	is measured under RF conditions.				

6. Characteristics

Table 6. DC characteristics

 $T_i = 25$ °C; per section unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	V_{GS} = 0 V; I_D = 2.4 mA	[1]	104	-	-	V
V _{GS(th)}	gate-source threshold voltage	V_{DS} = 10 V; I_{D} = 240 mA	[1]	1.4	1.9	2.4	V
I _{DSS}	drain leakage current	V_{GS} = 0 V; V_{DS} = 50 V		-	-	2.8	μA
I _{DSX}	drain cut-off current	$\label{eq:VGS} \begin{array}{l} V_{GS} = V_{GS(th)} + 3.75 \; V; \\ V_{DS} = 10 \; V \end{array}$		-	38	-	A
I _{GSS}	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V		-	-	280	nA
R _{DS(on)}	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 V;$ $I_D = 8.5 A$	[1]	-	120	-	mΩ
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 50 V;$ f = 1 MHz	[2]	-	210	-	pF
C _{oss}	output capacitance	$V_{GS} = 0 V; V_{DS} = 50 V;$ f = 1 MHz		-	67	-	pF
C _{rss}	reverse transfer capacitance	$V_{GS} = 0 V; V_{DS} = 50 V;$ f = 1 MHz		-	1.35	-	pF

[1] I_D is the drain current.

[2] Capacitance values without internal matching.

Table 7.RF characteristics

RF characteristics in NXP production narrowband test circuit; $T_{case} = 25 \ ^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
2-Tone, c	ass-AB						
V_{DS}	drain-source voltage			-	50	-	V
I _{Dq}	quiescent drain current		[1]	-	1.3	-	А
$P_{L(AV)}$	average output power	f ₁ = 860 MHz; f ₂ = 860.1 MHz		250	-	-	W
G _p	power gain	f ₁ = 860 MHz; f ₂ = 860.1 MHz		20	21	-	dB
η_D	drain efficiency	f ₁ = 860 MHz; f ₂ = 860.1 MHz		42	46	-	%
IMD3	third-order intermodulation distortion	f ₁ = 860 MHz; f ₂ = 860.1 MHz		-	-34	-30	dBc

RF characteristics ... continued Table 7.

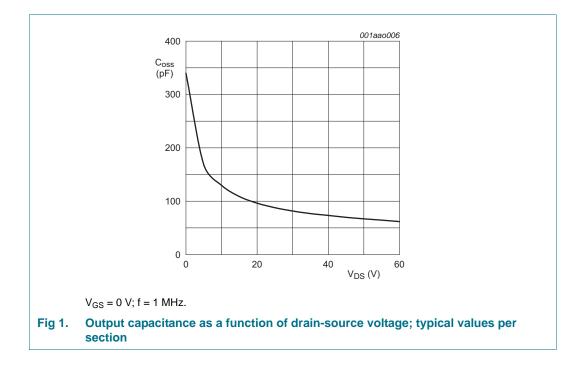
RF characteristics in NXP production narrowband test circuit; T_{case} = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
DVB-T (8	k OFDM), class-AB						
V _{DS}	drain-source voltage			-	50	-	V
I _{Dq}	quiescent drain current		[1]	-	1.3	-	А
P _{L(AV)}	average output power	f = 858 MHz		120	-	-	W
G _p	power gain	f = 858 MHz		20	21	-	dB
η_D	drain efficiency	f = 858 MHz		30	33	-	%
IMD _{shldr}	intermodulation distortion shoulder	f = 858 MHz	[2]	-	-31	-27	dBc
PAR	peak-to-average ratio	f = 858 MHz	[3]	-	8.2	-	dB

[1] I_{dq} for total device

Measured [dBc] with delta marker at 4.3 MHz from center frequency. [2]

[3] PAR (of output signal) at 0.01 % probability on CCDF; PAR of input signal = 9.5 dB at 0.01 % probability on CCDF.

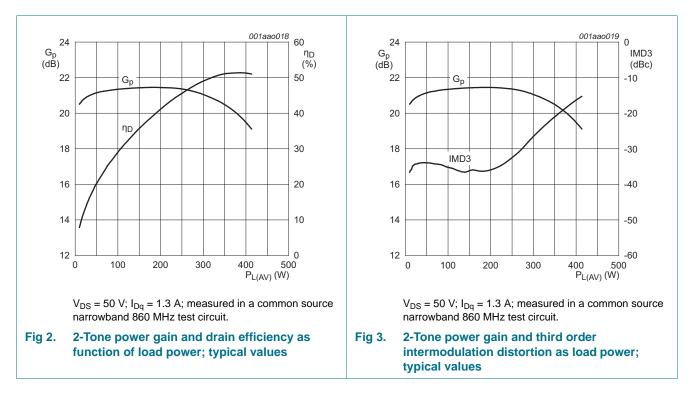


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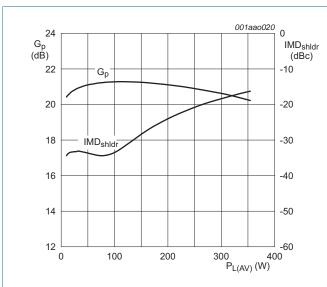
7. Application information

7.1 Narrowband RF figures

7.1.1 2-Tone



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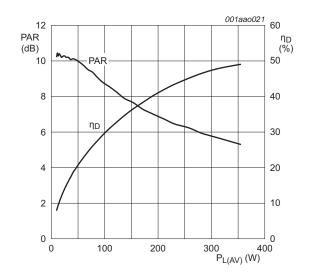
7.1.2 DVB-T

 V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source narrowband 860 MHz test circuit.

Fig 4. DVB-T power gain and intermodulation distortion shoulder as function of load power; typical values

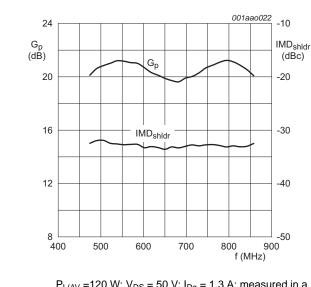
7.2.1 DVB-T

7.2 Broadband RF figures



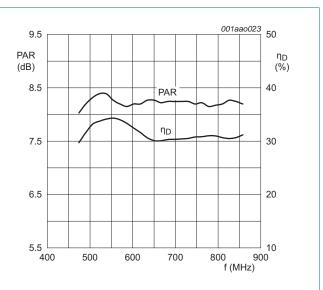
 V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source narrowband 860 MHz test circuit.

Fig 5. DVB-T peak-to-average ratio and drain efficiency as function of load power; typical values



 $P_{L(AV}$ =120 W; V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source broadband test circuit as described in <u>Section 8</u>.





 $P_{L(AV}$ =120 W; V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source broadband test circuit as described in <u>Section 8</u>.

Fig 7. DVB-T peak-to-average ratio and drain efficiency as function of frequency; typical values

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BLF888B BLF888BS

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7.3 Impedance information

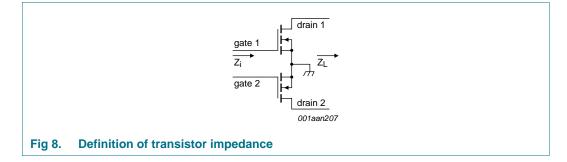


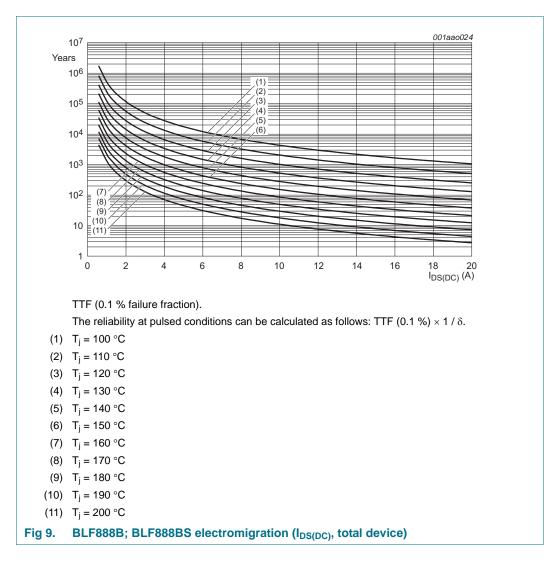
Table 8. Typical push-pull impedance

Simulated Z_i and Z_L device impedance; impedance info at $V_{DS} = 50$ V and $P_{L(AV)} = 120$ W (DVB-T).

f	Zi	ZL
MHz	Ω	Ω
300	0.617 – j1.715	4.792 + j0.947
325	0.635 – j1.355	4.707 + j0.994
350	0.655 – j1.026	4.619 + j1.035
375	0.677 – j0.721	4.528 + j1.069
400	0.702 – j0.435	4.435 + j1.097
425	0.731 – j0.164	4.340 + j1.118
450	0.762 + j0.096	4.243 + j1.134
475	0.798 + j0.347	4.147 + j1.143
500	0.839 + j0.592	4.049 + j1.146
525	0.884 + j0.833	3.952 + j1.144
550	0.936 + j1.072	3.855 + j1.136
575	0.995 + j1.310	3.759 + j1.123
600	1.063 + j1.549	3.663 + j1.105
625	1.141 + j1.791	3.569 + j1.083
650	1.230 + j2.037	3.477 + j1.055
675	1.334 + j2.289	3.385 + j1.024
700	1.456 + j2.548	3.296 + j0.989
725	1.599 + j2.814	3.209 + j0.949
750	1.768 + j3.090	3.123 + j0.907
775	1.971 + j3.376	3.039 + j0.861
800	2.214 + j3.671	2.958 + j0.812
825	2.510 + j3.975	2.879 + j0.761
850	2.873 + j4.282	2.801 + j0.706
875	3.320 + j4.584	2.726 + j0.650
900	3.875 + j4.865	2.654 + j0.591
925	4.562 + j5.095	2.583 + j0.530
950	5.409 + j5.223	2.514 + j0.467
975	6.426 + j5.166	2.448 + j0.403
1000	7.587 + j4.807	2.384 + j0.337

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7.4 Reliability



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8. Test information

Table 9. List of components For test circuit, see Figure 10, Figure 11 and Figure 12. Component Description Value Remarks B1, B2 semi rigid coax 25 Ω; 49.5 mm UT-090C-25 (EZ 90-25) [1] C1 multilayer ceramic chip capacitor 12 pF [1] C2, C3, C4, C5, multilayer ceramic chip capacitor 8.2 pF C6 C7 multilayer ceramic chip capacitor 6.8 pF [2] [2] C8 multilayer ceramic chip capacitor 2.7 pF [2] C9 2.2 pF multilayer ceramic chip capacitor C10, C13, C14 multilayer ceramic chip capacitor 100 pF [3] C11, C12 [2] multilayer ceramic chip capacitor 10 pF Kemet C1210X475K5RAC-TU or C15, C16 4.7 μF, 50 V multilayer ceramic chip capacitor capacitor of same quality. 100 pF [2] C17, C18, C23, multilayer ceramic chip capacitor C24 C19, C20 multilayer ceramic chip capacitor TDK C570X7R1H106KT000N or 10 µF, 50 V capacitor of same quality. C21, C22 470 μF; 63 V electrolytic capacitor [4] C30 multilayer ceramic chip capacitor 10 pF [4] C31 multilayer ceramic chip capacitor 9.1 pF [4] C32 multilayer ceramic chip capacitor 3.9 pF [4] C33, C34, C35 multilayer ceramic chip capacitor 100 pF TDK C4532X7R1E475MT020U or C36. C37 multilayer ceramic chip capacitor 4.7 μF, 50 V capacitor of same quality. L1 [5] (W \times L) 15 mm \times 13 mm microstrip _ L2 [5] $(W \times L) 5 mm \times 26 mm$ microstrip L3. L32 [5] $(W \times L) 2 \text{ mm} \times 49.5 \text{ mm}$ microstrip _ [5] L4 microstrip $(W \times L)$ 1.7 mm \times 3.5 mm _ L5 [5] $(W \times L) 2 \text{ mm} \times 9.5 \text{ mm}$ microstrip -L30 [5] $(W \times L) 5 \text{ mm} \times 13 \text{ mm}$ microstrip -L31 microstrip _ [5] $(W \times L) 2 \text{ mm} \times 11 \text{ mm}$ L33 [5] $(W \times L) 2 mm \times 3 mm$ microstrip -R1, R2 **10** Ω wire resistor R3, R4 SMD resistor 5.6 Ω 0805 R5. R6 wire resistor **100** Ω 10 kΩ R7, R8 potentiometer

[1] American technical ceramics type 800R or capacitor of same quality.

[2] American technical ceramics type 800B or capacitor of same quality.

[3] American technical ceramics type 180R or capacitor of same quality.

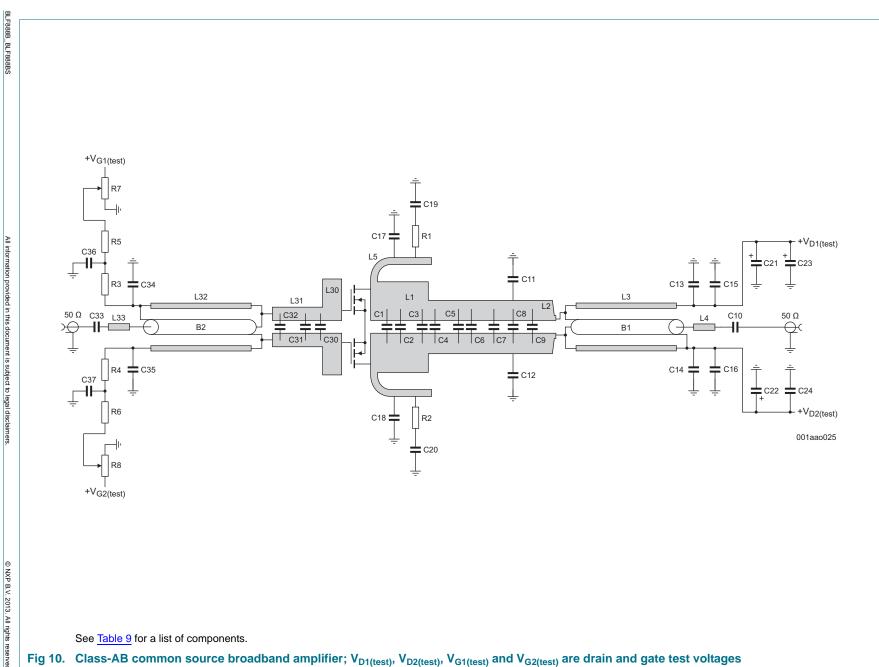
[4] American technical ceramics type 100A or capacitor of same quality.

[5] Printed-Circuit Board (PCB): Taconic RF35; ε_r = 3.5 F/m; height = 0.762 mm; Cu (top/bottom metallization); thickness copper plating = 35 μ m.

Product data sheet





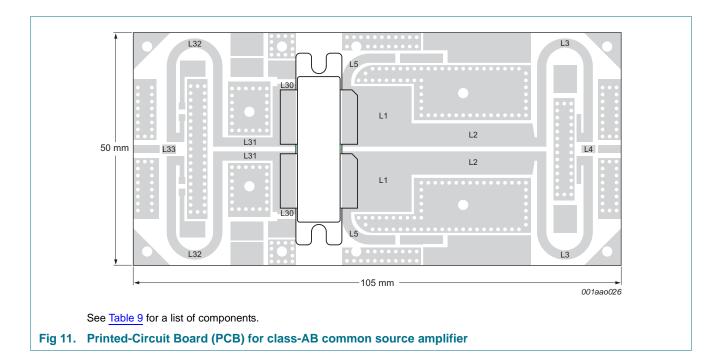


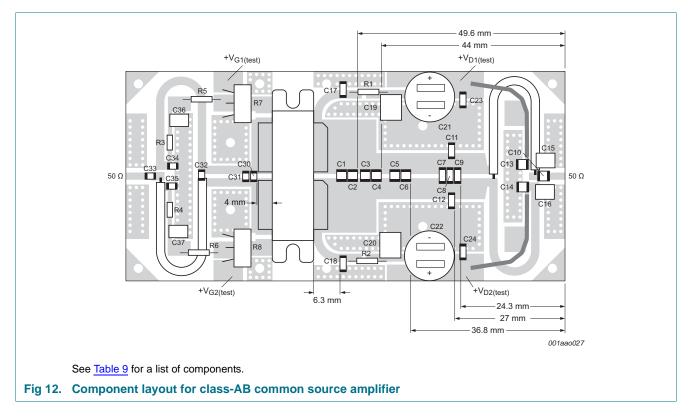
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9. Package outline

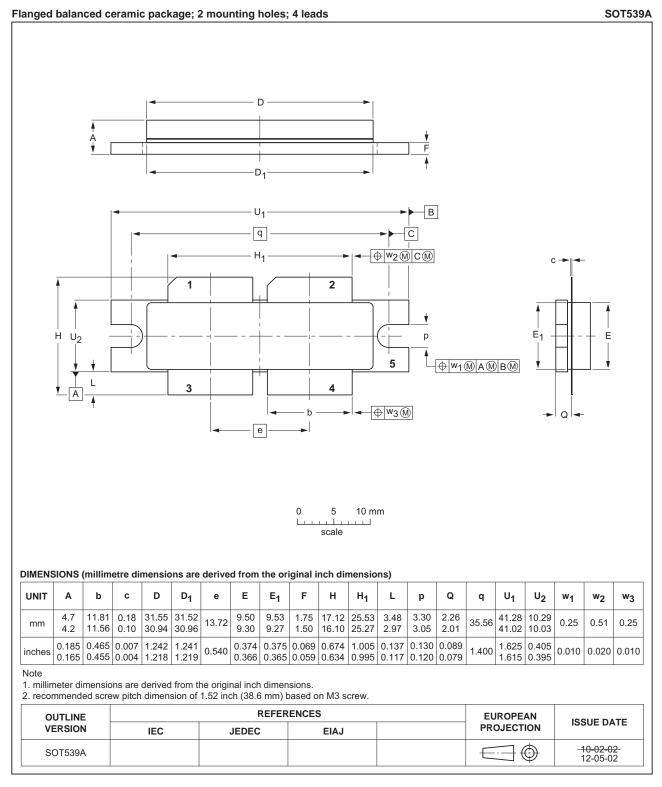


Fig 13. Package outline SOT539A

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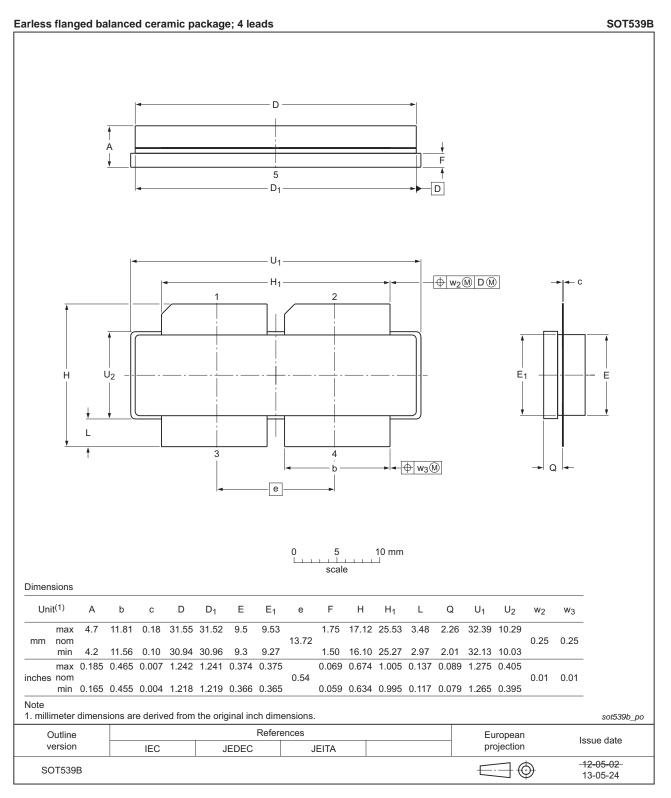


Fig 14. Package outline SOT539B

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10. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

11. Abbreviations

Table 10.	Abbreviations
Acronym	Description
CCDF	Complementary Cumulative Distribution Function
DVB	Digital Video Broadcast
DVB-T	Digital Video Broadcast - Terrestrial
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
OFDM	Orthogonal Frequency Division Multiplexing
PAR	Peak-to-Average power Ratio
RF	Radio Frequency
SMD	Surface Mounted Device
TTF	Time-To-Failure
UHF	Ultra High Frequency
VSWR	Voltage Standing-Wave Ratio

12. Revision history

Table 11. Revision histor	у			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF888B_BLF888BS v.2	20130712	Product data sheet	-	BLF888B_BLF888BS v.1
Modifications:	 The package 	ge outline <u>Figure 14</u> is up	odated.	
	 Translation 	disclaimer added to the	legal text.	
BLF888B_BLF888BS v.1	20111017	Product data sheet	-	-

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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ICs with DVB-T or DVB-T2 functionality

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